

Notice of References Cited	Application/Control No. 10/775,017	Applicant(s)/Patent Under Reexamination FUJIWARA ET AL.	
	Examiner Ida M. Soward	Art Unit 2822	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,849,884	02-2005	Clark et al.	257/192
	B	US-2003/0178670	09-2003	Fried et al.	257/315
	C	US-6,413,802	07-2002	Hu et al.	438/151
	D	US-2005/0093154	05-2005	Kottantharayil et al.	257/745
	E	US-6,888,181	05-2005	Liao et al.	257/192
	F	US-2004/0235300	11-2004	Mathew et al.	438/689
	G	US-2004/0262688	12-2004	Nowak et al.	257/350
	H	US-6,838,322	01-2005	Pham et al.	438/151
	I	US-2004/0203211	10-2004	Yang et al.	438/299
	J	US-2005/0023633	02-2005	Yeo et al.	257/500
	K	US-6,525,403	02-2003	Inaba et al.	257/618
	L	US-2004/0061191	04-2004	Paton et al.	257/412
	M	US-2004/0222477	11-2004	Aller et al.	257/412

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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